## Notice of References Cited Application/Control No. 10/701,749 Examiner Willie J. Daniel, Jr. Applicant(s)/Patent Under Reexamination MOCK ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0169008	11-2002	Hiben et al.	455/574
	В	US-2002/0086718	07-2002	Bigwood et al.	455/572
	С	US-6,427,072	07-2002	Reichelt, Martin	455/404.1
	D	US-2004/0121767	06-2004	Simpson et al.	455/426.1
	E	US-6,385,469	05-2002	Alperovich et al.	455/574
	F	US-			
	G	US			
	Н	US-			
	_	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	s					
,	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.